

<b>Notice of References Cited</b>	Application/Control No. 10/791,967		Applicant(s)/Patent Under Reexamination TALUKDAR ET AL.	
	Examiner Hanh Nguyen		Art Unit 2616	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,117,411	10-2006	McNeely et al.	714/724
*	C	US-6,889,339	05-2005	D'Amico et al.	714/4
*	D	US-6,138,163	10-2000	Nam et al.	709/231
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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